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PATENT NUMBER and
ISSUE DATE

U.S. UTILITY Patent Application

APPL NUM 10042032	FILING DATE 10/25/2001	CLASS 356	SUBCLASS 234.1	GAU 2877	EXAMINER T. NGUYEN
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**CONTINUING DATA VERIFIED:

THIS APPLICATION IS A DIV OF 09/158,362 09/22/1998

** FOREIGN APPLICATIONS VERIFIED:

JAPAN 9-258552 09/24/1997

JAPAN 10-264342 09/18/1998

PG-PUB	DO NOT PUBLISH <input type="checkbox"/>	RESCIND <input type="checkbox"/>
Foreign priority claimed	<input type="checkbox"/> yes <input type="checkbox"/> no	ATTORNEY DOCKET NO
35 USC 119 conditions met	<input type="checkbox"/> yes <input type="checkbox"/> no	980615CD/LH
Verified and Acknowledged Examiners's initials		
TITLE : Apparatus for inspecting a substrate		
U.S. DEPT. OF COMM./PAT & TM-PTO-436L(Rev. 12-94)		

NOTICE OF ALLOWANCE MAILED		CLAIMS ALLOWED	
		Total Claims	Print Claim for O.G.
		DRAWING	
ISSUE FEE		Sheets Drawn. <input type="checkbox"/> Figs. Drawn. <input type="checkbox"/> Print Fig. <input type="checkbox"/>	
Amount Due	Date Paid		
TERMINAL		Primary Examiner	
DISCLAIMER		PREPARED F R ISSUE	
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